Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10568392	MIHARA ET AL.
Examiner	Art Unit
Chang-Yu Wang	1649

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Sequence search: SEQ ID NO:1 regular and oligomer search. See search results in SCORE (7/1/08).	9/2/08	CYW
EAST, STN: search strategy attached	9/2/08	CYW
Inventor name search: EAST, STN, PALM	9/2/08	CYW
PLUS search from STIC. See search results in eDAN (7/1/08).	9/2/08	CYW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/C. Y.W./ Examiner.Art Unit 1649	

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